


Search Notes 	Application/Control No. 10799139	Applicant(s)/Patent Under Reexamination DUFF ET AL.
	Examiner Flores, Leon	Art Unit 2611

SEARCHED			
Class	Subclass	Date	Examiner
375	316, 376	4/9/2007	LF
375	354, 355	9/29/2007	LF

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with SPE David Payne in regards to the patentability of the claims.	4/13/2007	LF
Checked for double patenting.	4/9/2007	LF
Search in IEEE	4/9/2007	LF
Consulted with SPE David Payne in regards to the amendment.	10/10/2007	LF
Consulted with SPE David Payne in regards to the amendments.	4/9/2008	LF
Consulted with SPE David Payne in regards to the new ground of rejection.	12/30/2009	LF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/L. F./
Examiner, Art Unit 2611